



Document

**Appendix D for the BlackBerry® Smartphone Model  
RDM71UW/RDN71UW**Page  
**1(55)**

Author Data <b>Hang Wang</b>	Dates of Test <b>Jan 11 – Feb 15, 2011</b>	Test Report No <b>RTS-3640-1102-04a</b>	FCC ID: <b>L6ARDM70UW</b> <b>L6ARDN70UW</b>	IC ID <b>2503A-RDM70UW</b> <b>2503A-RDN70UW</b>
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**APPENDIX D: PROBE & DIPOLE CALIBRATION DATA**



Document

**Appendix D for the BlackBerry® Smartphone Model  
RDM71UW/RDN71UW**

Page  
**2(55)**

Author Data <b>Hang Wang</b>	Dates of Test <b>Jan 11 – Feb 15, 2011</b>	Test Report No <b>RTS-3640-1102-04a</b>	FCC ID: <b>L6ARDM70UW</b> <b>L6ARDN70UW</b>	IC ID <b>2503A-RDM70UW</b> <b>2503A-RDN70UW</b>
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**Calibration Laboratory of**  
Schmid & Partner  
Engineering AG  
Zeughausstrasse 43, 8004 Zurich, Switzerland



**S** Schweizerischer Kalibrierdienst  
**C** Service suisse d'étalonnage  
**S** Servizio svizzero di taratura  
**S** Swiss Calibration Service

Accredited by the Swiss Accreditation Service (SAS)  
The Swiss Accreditation Service is one of the signatories to the EA  
Multilateral Agreement for the recognition of calibration certificates

Accreditation No.: **SCS 108**Client **RTS (RIM Testing Services)**Certificate No: **ET3-1643\_Mar10**

## **CALIBRATION CERTIFICATE**

Object **ET3DV6 ~ SN:1643**Calibration procedure(s) **QA CAL-01.v6, QA CAL-23.v3 and QA CAL-25.v2**  
**Calibration procedure for dosimetric E-field probes**Calibration date: **March 9, 2010**

This calibration certificate documents the traceability to national standards, which realize the physical units of measurements (SI).  
The measurements and the uncertainties with confidence probability are given on the following pages and are part of the certificate.

All calibrations have been conducted in the closed laboratory facility; environment temperature (22 ± 3)°C and humidity &lt; 70%.

Calibration Equipment used (M&amp;TE critical for calibration)

Primary Standards	ID #	Cal Date (Certificate No.)	Scheduled Calibration
Power meter E4419B	GB41293874	1-Apr-09 (No. 217-01030)	Apr-10
Power sensor E4412A	MY41495277	1-Apr-09 (No. 217-01030)	Apr-10
Power sensor E4412A	MY41498087	1-Apr-09 (No. 217-01030)	Apr-10
Reference 3 dB Attenuator	SN: S5054 (3c)	31-Mar-09 (No. 217-01026)	Mar-10
Reference 20 dB Attenuator	SN: S5086 (20b)	31-Mar-09 (No. 217-01028)	Mar-10
Reference 30 dB Attenuator	SN: S5129 (30b)	31-Mar-09 (No. 217-01027)	Mar-10
Reference Probe ES3DV2	SN: 3013	30-Dec-09 (No. ES3-3013_Dec09)	Dec-10
DAE4	SN: 660	29-Sep-09 (No. DAE4-660_Sep09)	Sep-10

Secondary Standards	ID #	Check Date (in house)	Scheduled Check
RF generator HP 8648C	US3642U01700	4-Aug-99 (in house check Oct-09)	In house check: Oct-11
Network Analyzer HP 8753E	US37390585	18-Oct-01 (in house check Oct-09)	In house check: Oct10

Calibrated by:	Name	Function	Signature
	Jeton Kastrati	Laboratory Technician	

Approved by:	Name	Function	Signature
	Katja Pokovic	Technical Manager	

Issued: March 10, 2010

This calibration certificate shall not be reproduced except in full without written approval of the laboratory.

Certificate No: **ET3-1643\_Mar10**

Page 1 of 11

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### Glossary:

<b>TSL</b>	tissue simulating liquid
<b>NORM<sub>x,y,z</sub></b>	sensitivity in free space
<b>ConvF</b>	sensitivity in TSL / NORM <sub>x,y,z</sub>
<b>DCP</b>	diode compression point
<b>CF</b>	crest factor (1/duty_cycle) of the RF signal
<b>A, B, C</b>	modulation dependent linearization parameters
<b>Polarization <math>\varphi</math></b>	$\varphi$ rotation around probe axis
<b>Polarization <math>\theta</math></b>	$\theta$ rotation around an axis that is in the plane normal to probe axis (at measurement center), i.e., $\theta = 0$ is normal to probe axis

### Calibration is Performed According to the Following Standards:

- IEEE Std 1528-2003, "IEEE Recommended Practice for Determining the Peak Spatial-Averaged Specific Absorption Rate (SAR) in the Human Head from Wireless Communications Devices: Measurement Techniques", December 2003
- IEC 62209-1, "Procedure to measure the Specific Absorption Rate (SAR) for hand-held devices used in close proximity to the ear (frequency range of 300 MHz to 3 GHz)", February 2005

### Methods Applied and Interpretation of Parameters:

- NORM<sub>x,y,z</sub>**: Assessed for E-field polarization  $\theta = 0$  ( $f \leq 900$  MHz in TEM-cell;  $f > 1800$  MHz: R22 waveguide). NORM<sub>x,y,z</sub> are only intermediate values, i.e., the uncertainties of NORM<sub>x,y,z</sub> does not effect the E-field uncertainty inside TSL (see below **ConvF**).
- NORM(f)x,y,z = NORM<sub>x,y,z</sub> \* frequency\_response** (see Frequency Response Chart). This linearization is implemented in DASY4 software versions later than 4.2. The uncertainty of the frequency response is included in the stated uncertainty of **ConvF**.
- DCPx,y,z**: DCP are numerical linearization parameters assessed based on the data of power sweep with CW signal (no uncertainty required). DCP does not depend on frequency nor media.
- Ax,y,z; Bx,y,z; Cx,y,z; VRx,y,z; A, B, C** are numerical linearization parameters assessed based on the data of power sweep for specific modulation signal. The parameters do not depend on frequency nor media. VR is the maximum calibration range expressed in RMS voltage across the diode.
- ConvF and Boundary Effect Parameters**: Assessed in flat phantom using E-field (or Temperature Transfer Standard for  $f \leq 800$  MHz) and inside waveguide using analytical field distributions based on power measurements for  $f > 800$  MHz. The same setups are used for assessment of the parameters applied for boundary compensation (alpha, depth) of which typical uncertainty values are given. These parameters are used in DASY4 software to improve probe accuracy close to the boundary. The sensitivity in TSL corresponds to **NORM<sub>x,y,z</sub> \* ConvF** whereby the uncertainty corresponds to that given for **ConvF**. A frequency dependent **ConvF** is used in DASY version 4.4 and higher which allows extending the validity from  $\pm 50$  MHz to  $\pm 100$  MHz.
- Spherical isotropy (3D deviation from isotropy)**: in a field of low gradients realized using a flat phantom exposed by a patch antenna.
- Sensor Offset**: The sensor offset corresponds to the offset of virtual measurement center from the probe tip (on probe axis). No tolerance required.



Document

**Appendix D for the BlackBerry® Smartphone Model  
RDM71UW/RDN71UW**Page  
**4(55)**

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Document

**Appendix D for the BlackBerry® Smartphone Model  
RDM71UW/RDN71UW**Page  
**5(55)**

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**ET3DV6 SN:1643****March 9, 2010**

# Probe ET3DV6

## SN:1643

Manufactured: November 7, 2001  
Last calibrated: March 10, 2009  
Recalibrated: March 9, 2010

### Calibrated for DASY Systems

(Note: non-compatible with DASY2 system!)



Document

**Appendix D for the BlackBerry® Smartphone Model  
RDM71UW/RDN71UW**Page  
**6(55)**

Author Data <b>Hang Wang</b>	Dates of Test <b>Jan 11 – Feb 15, 2011</b>	Test Report No <b>RTS-3640-1102-04a</b>	FCC ID: <b>L6ARDM70UW</b> <b>L6ARDN70UW</b>	IC ID <b>2503A-RDM70UW</b> <b>2503A-RDN70UW</b>
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**ET3DV6 SN:1643****March 9, 2010****DASY - Parameters of Probe: ET3DV6 SN:1643****Basic Calibration Parameters**

	Sensor X	Sensor Y	Sensor Z	Unc (k=2)
Norm ( $\mu$ V/(V/m) <sup>2</sup> ) <sup>A</sup>	1.75	2.01	1.79	$\pm$ 10.1%
DCP (mV) <sup>B</sup>	93.2	91.0	90.9	

**Modulation Calibration Parameters**

UID	Communication System Name	PAR		A dB	B dBuV	C	VR mV	Unc <sup>E</sup> (k=2)
10000	CW	0.00	X	0.00	0.00	1.00	300.0	$\pm$ 1.5%
			Y	0.00	0.00	1.00	300.0	
			Z	0.00	0.00	1.00	300.0	

The reported uncertainty of measurement is stated as the standard uncertainty of measurement multiplied by the coverage factor k=2, which for a normal distribution corresponds to a coverage probability of approximately 95%.

<sup>A</sup> The uncertainties of NormX,Y,Z do not affect the E-field uncertainty inside TSL (see Pages 5 and 6).<sup>B</sup> Numerical linearization parameter: uncertainty not required.<sup>E</sup> Uncertainty is determined using the maximum deviation from linear response applying rectangular distribution and is expressed for the square of the field value.



Document

**Appendix D for the BlackBerry® Smartphone Model  
RDM71UW/RDN71UW**Page  
**7(55)**

Author Data <b>Hang Wang</b>	Dates of Test <b>Jan 11 – Feb 15, 2011</b>	Test Report No <b>RTS-3640-1102-04a</b>	FCC ID: <b>L6ARDM70UW</b> <b>L6ARDN70UW</b>	IC ID <b>2503A-RDM70UW</b> <b>2503A-RDN70UW</b>
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Document

**Appendix D for the BlackBerry® Smartphone Model  
RDM71UW/RDN71UW**Page  
**8(55)**

Author Data <b>Hang Wang</b>	Dates of Test <b>Jan 11 – Feb 15, 2011</b>	Test Report No <b>RTS-3640-1102-04a</b>	FCC ID: <b>L6ARDM70UW</b> <b>L6ARDN70UW</b>	IC ID <b>2503A-RDM70UW</b> <b>2503A-RDN70UW</b>
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**ET3DV6 SN:1643****March 9, 2010****DASY - Parameters of Probe: ET3DV6 SN:1643****Calibration Parameter Determined in Head Tissue Simulating Media**

<b>f [MHz]</b>	<b>Validity [MHz]<sup>c</sup></b>	<b>Permittivity</b>	<b>Conductivity</b>	<b>ConvF X</b>	<b>ConvF Y</b>	<b>ConvF Z</b>	<b>Alpha</b>	<b>Depth Unc (k=2)</b>
900	$\pm 50 / \pm 100$	$41.5 \pm 5\%$	$0.97 \pm 5\%$	6.01	6.01	6.01	0.42	$2.35 \pm 11.0\%$
1810	$\pm 50 / \pm 100$	$40.0 \pm 5\%$	$1.40 \pm 5\%$	4.99	4.99	4.99	0.62	$2.35 \pm 11.0\%$
1950	$\pm 50 / \pm 100$	$40.0 \pm 5\%$	$1.40 \pm 5\%$	4.74	4.74	4.74	0.79	$2.10 \pm 11.0\%$

<sup>c</sup> The validity of  $\pm 100$  MHz only applies for DASY v4.4 and higher (see Page 2). The uncertainty is the RSS of the ConvF uncertainty at calibration frequency and the uncertainty for the indicated frequency band.



Document

**Appendix D for the BlackBerry® Smartphone Model  
RDM71UW/RDN71UW**Page  
**9(55)**

Author Data <b>Hang Wang</b>	Dates of Test <b>Jan 11 – Feb 15, 2011</b>	Test Report No <b>RTS-3640-1102-04a</b>	FCC ID: <b>L6ARDM70UW</b> <b>L6ARDN70UW</b>	IC ID <b>2503A-RDM70UW</b> <b>2503A-RDN70UW</b>
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**ET3DV6 SN:1643****March 9, 2010****DASY - Parameters of Probe: ET3DV6 SN:1643****Calibration Parameter Determined in Body Tissue Simulating Media**

<b>f [MHz]</b>	<b>Validity [MHz]<sup>c</sup></b>	<b>Permittivity</b>	<b>Conductivity</b>	<b>ConvF X</b>	<b>ConvF Y</b>	<b>ConvF Z</b>	<b>Alpha</b>	<b>Depth Unc (k=2)</b>
900	$\pm 50 / \pm 100$	55.0 $\pm$ 5%	1.05 $\pm$ 5%	5.93	5.93	5.93	0.33	2.77 $\pm$ 11.0%
1810	$\pm 50 / \pm 100$	53.3 $\pm$ 5%	1.52 $\pm$ 5%	4.58	4.58	4.58	0.75	2.63 $\pm$ 11.0%
1950	$\pm 50 / \pm 100$	53.3 $\pm$ 5%	1.52 $\pm$ 5%	4.54	4.54	4.54	0.99	2.20 $\pm$ 11.0%

<sup>c</sup> The validity of  $\pm 100$  MHz only applies for DASY v4.4 and higher (see Page 2). The uncertainty is the RSS of the ConvF uncertainty at calibration frequency and the uncertainty for the indicated frequency band.



Document

**Appendix D for the BlackBerry® Smartphone Model  
RDM71UW/RDN71UW**Page  
**10(55)**Author Data  
**Hang Wang**

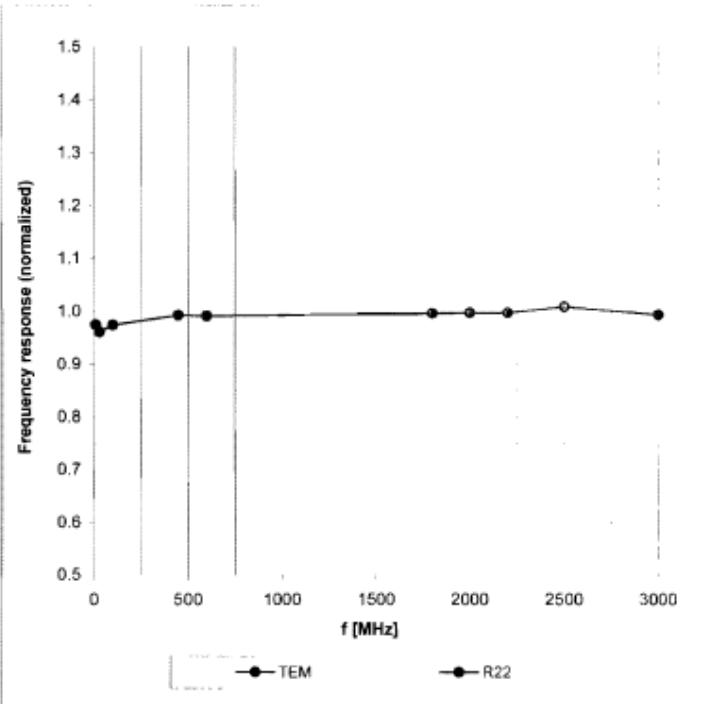
Dates of Test

**Jan 11 – Feb 15, 2011**

Test Report No

**RTS-3640-1102-04a**

FCC ID:

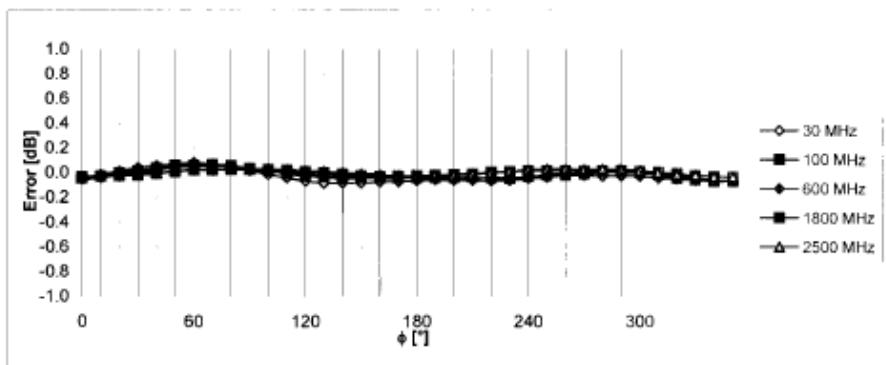
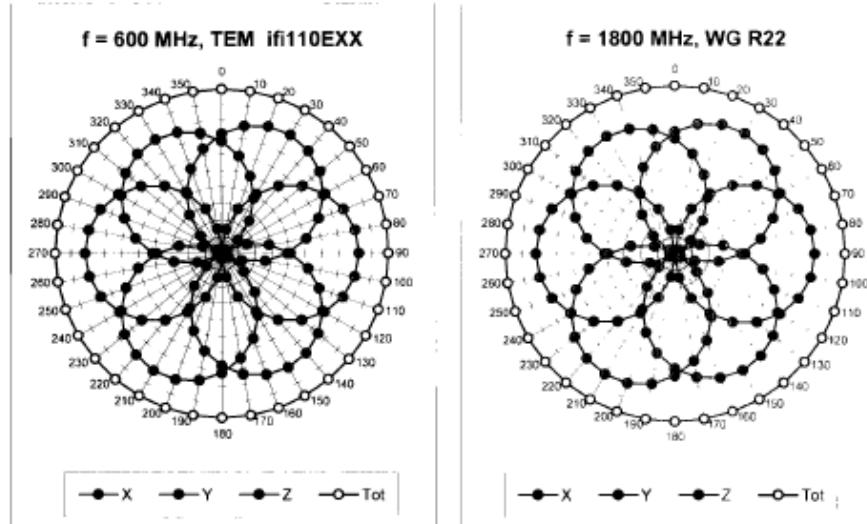
**L6ARDM70UW  
L6ARDN70UW**IC ID  
**2503A-RDM70UW  
2503A-RDN70UW****ET3DV6 SN:1643****March 9, 2010****Frequency Response of E-Field****(TEM-Cell:ifi110 EXX, Waveguide: R22)****Uncertainty of Frequency Response of E-field:  $\pm 6.3\%$  ( $k=2$ )**

Author Data <b>Hang Wang</b>	Dates of Test <b>Jan 11 – Feb 15, 2011</b>	Test Report No <b>RTS-3640-1102-04a</b>	FCC ID: <b>L6ARDM70UW</b> <b>L6ARDN70UW</b>	IC ID <b>2503A-RDM70UW</b> <b>2503A-RDN70UW</b>
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ET3DV6 SN:1643

March 9, 2010

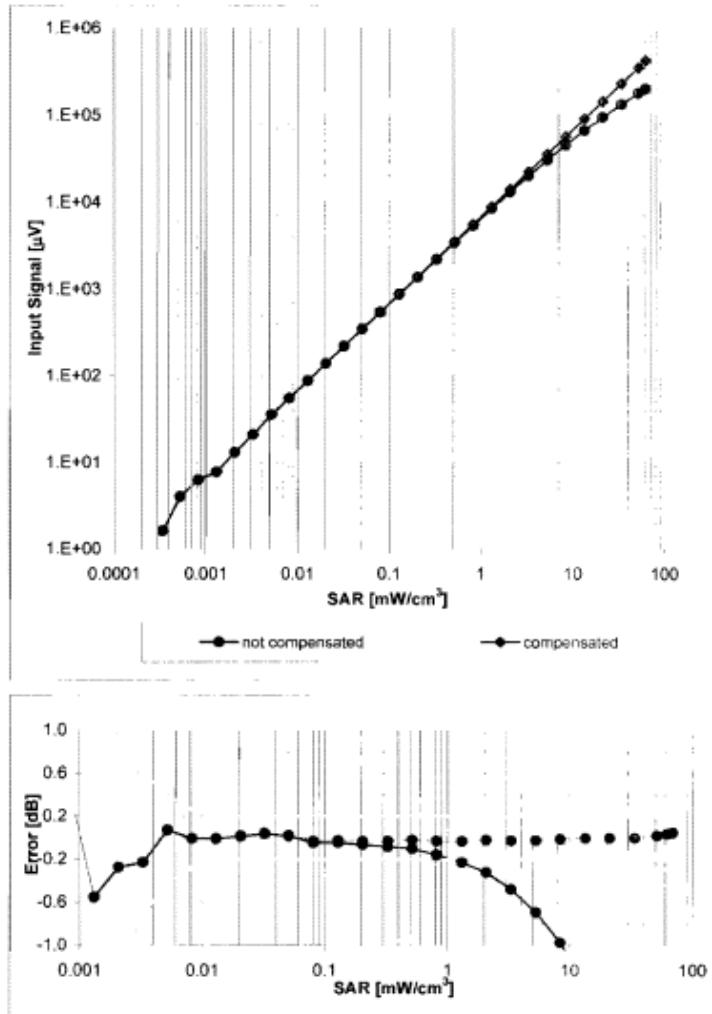
### Receiving Pattern ( $\phi$ ), $\theta = 0^\circ$


 Uncertainty of Axial Isotropy Assessment:  $\pm 0.5\%$  ( $k=2$ )

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**ET3DV6 SN:1643**
**March 9, 2010**

**Dynamic Range  $f(\text{SAR}_{\text{head}})$**   
 (Waveguide R22,  $f = 1800$  MHz)

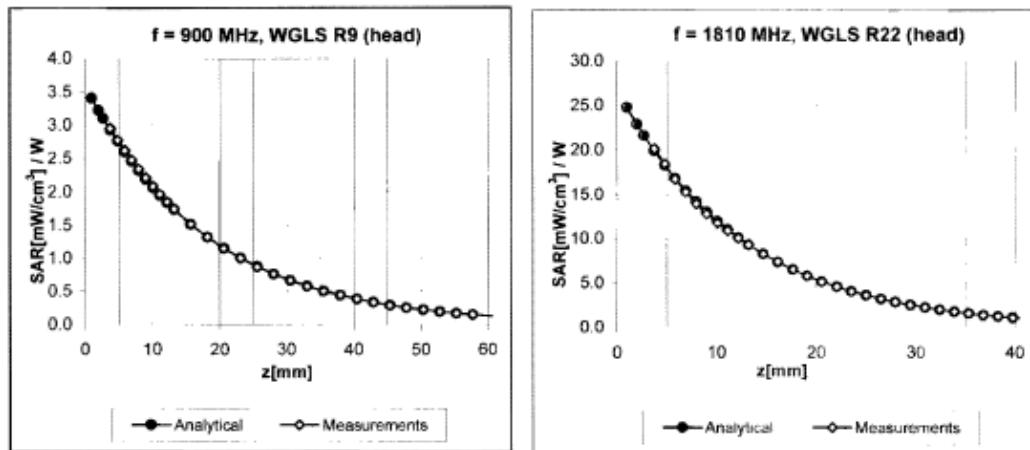

**Uncertainty of Linearity Assessment:  $\pm 0.6\%$  ( $k=2$ )**

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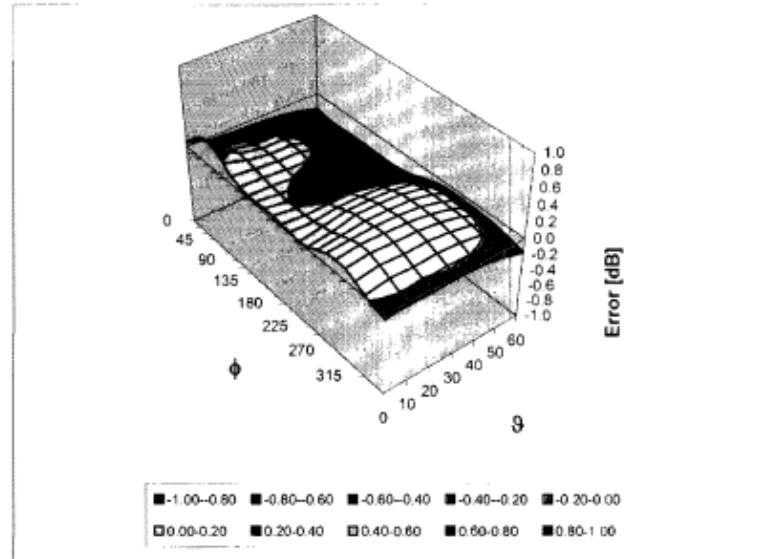
ET3DV6 SN:1643

March 9, 2010

## Conversion Factor Assessment



## Deviation from Isotropy in HSL

Error ( $\phi, \theta$ ), f = 900 MHzUncertainty of Spherical Isotropy Assessment:  $\pm 2.6\%$  ( $k=2$ )



Document

**Appendix D for the BlackBerry® Smartphone Model  
RDM71UW/RDN71UW**Page  
**14(55)**

Author Data <b>Hang Wang</b>	Dates of Test <b>Jan 11 – Feb 15, 2011</b>	Test Report No <b>RTS-3640-1102-04a</b>	FCC ID: <b>L6ARDM70UW</b> <b>L6ARDN70UW</b>	IC ID <b>2503A-RDM70UW</b> <b>2503A-RDN70UW</b>
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**ET3DV6 SN:1643****March 9, 2010****Other Probe Parameters**

Sensor Arrangement	Triangular
Connector Angle (°)	Not applicable
Mechanical Surface Detection Mode	enabled
Optical Surface Detection Mode	enabled
Probe Overall Length	337 mm
Probe Body Diameter	10 mm
Tip Length	10 mm
Tip Diameter	6.8 mm
Probe Tip to Sensor X Calibration Point	2.7 mm
Probe Tip to Sensor Y Calibration Point	2.7 mm
Probe Tip to Sensor Z Calibration Point	2.7 mm
Recommended Measurement Distance from Surface	4 mm



Document

**Appendix D for the BlackBerry® Smartphone Model  
RDM71UW/RDN71UW**

Page  
**15(55)**

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Accreditation No.: **SCS 108**Client **RTS (RIM Testing Services)**Certificate No: **ET3-1644\_Nov10**

## **CALIBRATION CERTIFICATE**

Object	<b>ET3DV6 - SN:1644</b>
Calibration procedure(s)	<b>QA CAL-01.v6, QA CAL-23.v3 and QA CAL-25.v2</b> Calibration procedure for dosimetric E-field probes
Calibration date	<b>November 16, 2010</b>

This calibration certificate documents the traceability to national standards, which realize the physical units of measurements (SI). The measurements and the uncertainties with confidence probability are given on the following pages and are part of the certificate.

All calibrations have been conducted in the closed laboratory facility, environment temperature  $(22 \pm 3)^\circ\text{C}$  and humidity  $< 70\%$ .

Calibration Equipment used (M&TE critical for calibration)

Primary Standards	ID #	Cal Date (Certificate No.)	Scheduled Calibration
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Power sensor E4412A	MY41495277	1-Apr-10 (No. 217-01138)	Apr-11
Power sensor E4412A	MY41498087	1-Apr-10 (No. 217-01136)	Apr-11
Reference 3-dB Attenuator	SN: 51054 (3c)	30-Mar-10 (No. 217-01159)	Mar-11
Reference 20-dB Attenuator	SN: 83006 (20c)	30-Mar-10 (No. 217-01161)	Mar-11
Reference 30-dB Attenuator	SN: 85129 (30c)	30-Mar-10 (No. 217-01160)	Mar-11
Reference Probe E33DV2	SN: 3013	30-Dec-09 (No. E33-3013_Doc09)	Dec-10
DAE4	SN: 860	20-Apr-10 (No. DAE4-860_Apr10)	Apr-11

Secondary Standards	ID #	Check Date (in house)	Scheduled Check
RF generator HP 8848C	US3642U01200	4-Aug-09 (in house check Oct-09)	In house check Oct-11
Network Analyzer HP 8753E	US37390585	18-Oct-09 (in house check Oct-10)	In house check Oct-11

Calibrated by:	Name <b>Jelon Kastell</b>	Function <b>Laboratory Technician</b>	Signature 
Approved by:	Name <b>Kaja Potonic</b>	Function <b>Technical Manager</b>	Signature 

Issued: November 17, 2010

This calibration certificate shall not be reproduced except in full without written approval of the laboratory

Certificate No: **ET3-1644\_Nov10**

Page 1 of 11



Document

**Appendix D for the BlackBerry® Smartphone Model  
RDM71UW/RDN71UW**
Page  
**16(55)**

Author Data <b>Hang Wang</b>	Dates of Test <b>Jan 11 – Feb 15, 2011</b>	Test Report No <b>RTS-3640-1102-04a</b>	FCC ID: <b>L6ARDM70UW</b> <b>L6ARDN70UW</b>	IC ID <b>2503A-RDM70UW</b> <b>2503A-RDN70UW</b>
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A, B, C	modulation dependent linearization parameters
Polarization $\varphi$	$\varphi$ rotation around probe axis
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- DCPx,y,z: DCP are numerical linearization parameters assessed based on the data of power sweep with CW signal (no uncertainty required). DCP does not depend on frequency nor media.
- Ax,y,z; Bx,y,z; Cx,y,z; VRx,y,z: A, B, C are numerical linearization parameters assessed based on the data of power sweep for specific modulation signal. The parameters do not depend on frequency nor media. VR is the maximum calibration range expressed in RMS voltage across the diode.
- ConvF and Boundary Effect Parameters: Assessed in flat phantom using E-field (or Temperature Transfer Standard for  $f \leq 800$  MHz) and inside waveguide using analytical field distributions based on power measurements for  $f > 800$  MHz. The same setups are used for assessment of the parameters applied for boundary compensation (alpha, depth) of which typical uncertainty values are given. These parameters are used in DASY4 software to improve probe accuracy close to the boundary. The sensitivity in TSL corresponds to NORM<sub>x,y,z</sub> \* ConvF whereby the uncertainty corresponds to that given for ConvF. A frequency dependent ConvF is used in DASY version 4.4 and higher which allows extending the validity from  $\pm 50$  MHz to  $\pm 100$  MHz.
- Spherical Isotropy (3D deviation from isotropy): in a field of low gradients realized using a flat phantom exposed by a patch antenna.
- Sensor Offset: The sensor offset corresponds to the offset of virtual measurement center from the probe tip (on probe axis). No tolerance required.



Document

**Appendix D for the BlackBerry® Smartphone Model  
RDM71UW/RDN71UW**Page  
**17(55)**

Author Data <b>Hang Wang</b>	Dates of Test <b>Jan 11 – Feb 15, 2011</b>	Test Report No <b>RTS-3640-1102-04a</b>	FCC ID: <b>L6ARDM70UW</b> <b>L6ARDN70UW</b>	IC ID <b>2503A-RDM70UW</b> <b>2503A-RDN70UW</b>
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**ET3DV6 SN:1644****November 16, 2010**

# Probe ET3DV6

## SN:1644

Manufactured: November 7, 2001  
Last calibrated: November 11, 2009  
Recalibrated: November 16, 2010

**Calibrated for DASY/EASY Systems**

(Note: non-compatible with DASY2 system.)



Document

**Appendix D for the BlackBerry® Smartphone Model  
RDM71UW/RDN71UW**Page  
**18(55)**

Author Data <b>Hang Wang</b>	Dates of Test <b>Jan 11 – Feb 15, 2011</b>	Test Report No <b>RTS-3640-1102-04a</b>	FCC ID: <b>L6ARDM70UW</b> <b>L6ARDN70UW</b>	IC ID <b>2503A-RDM70UW</b> <b>2503A-RDN70UW</b>
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**ET3DV6 SN:1644****November 16, 2010****DASY/EASY - Parameters of Probe: ET3DV6 SN:1644****Basic Calibration Parameters**

		<b>Sensor X</b>	<b>Sensor Y</b>	<b>Sensor Z</b>	<b>Unc (k=2)</b>
<b>Norm (<math>\mu</math>V/(<math>\text{V}/\text{m}</math>)<sup>2</sup>)<sup>a</sup></b>		1.83	1.95	2.01	$\pm 10.1\%$
<b>DCP (mV)<sup>b</sup></b>		97.9	97.9	96.6	

**Modulation Calibration Parameters**

<b>UID</b>	<b>Communication System Name</b>	<b>PAR</b>		<b>A</b> <b>dB</b>	<b>B</b> <b>dBuV</b>	<b>C</b>	<b>VR</b> <b>mV</b>	<b>Unc<sup>c</sup></b> <b>(k=2)</b>
10000	CW	0.00	X Y Z	0.00 0.00 0.00	0.00 0.00 0.00	1.00 1.00 1.00	143.5 146.8 148.4	$\pm 3.4\%$

The reported uncertainty of measurement is stated as the standard uncertainty of measurement multiplied by the coverage factor k=2, which for a normal distribution corresponds to a coverage probability of approximately 95%.

<sup>a</sup> The uncertainties of Norm X Y Z do not affect the E<sup>2</sup> field uncertainty inside TBL (see Pages 6 and 8)<sup>b</sup> Numerical linearization parameter uncertainty not included.<sup>c</sup> Uncertainty is determined using the maximum deviation from linear response applying rectangular distribution and is expressed for the square of the field value.



Document

**Appendix D for the BlackBerry® Smartphone Model  
RDM71UW/RDN71UW**Page  
**19(55)**

Author Data <b>Hang Wang</b>	Dates of Test <b>Jan 11 – Feb 15, 2011</b>	Test Report No <b>RTS-3640-1102-04a</b>	FCC ID: <b>L6ARDM70UW</b> <b>L6ARDN70UW</b>	IC ID <b>2503A-RDM70UW</b> <b>2503A-RDN70UW</b>
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Document

**Appendix D for the BlackBerry® Smartphone Model  
RDM71UW/RDN71UW**Page  
**20(55)**

Author Data <b>Hang Wang</b>	Dates of Test <b>Jan 11 – Feb 15, 2011</b>	Test Report No <b>RTS-3640-1102-04a</b>	FCC ID: <b>L6ARDM70UW</b> <b>L6ARDN70UW</b>	IC ID <b>2503A-RDM70UW</b> <b>2503A-RDN70UW</b>
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**ET3DV6 SN:1644****November 16, 2010****DASY/EASY - Parameters of Probe: ET3DV6 SN:1644****Calibration Parameter Determined in Head Tissue Simulating Media**

f [MHz]	Validity [MHz] <sup>b</sup>	Permittivity	Conductivity	ConvF X	ConvF Y	ConvF Z	Alpha	Depth Unc (k=2)
760	± 50 / ± 100	41.9 ± 5%	0.89 ± 5%	6.64	6.54	6.54	0.31	3.05 ± 11.0%
900	± 50 / ± 100	41.5 ± 5%	0.97 ± 5%	6.00	6.00	6.00	0.27	3.46 ± 11.0%
1810	± 50 / ± 100	40.0 ± 5%	1.40 ± 5%	5.09	5.09	5.09	0.40	2.50 ± 11.0%
2450	± 50 / ± 100	39.2 ± 5%	1.80 ± 5%	4.42	4.42	4.42	0.99	1.27 ± 11.0%

<sup>b</sup> The validity of ± 100 MHz only applies for DASY v4.4 and higher (see Page 2). The uncertainty is the RSS of the ConvF uncertainty at calibration frequency and the uncertainty for the indicated frequency band.



Document

**Appendix D for the BlackBerry® Smartphone Model  
RDM71UW/RDN71UW**Page  
**21(55)**

Author Data <b>Hang Wang</b>	Dates of Test <b>Jan 11 – Feb 15, 2011</b>	Test Report No <b>RTS-3640-1102-04a</b>	FCC ID: <b>L6ARDM70UW</b> <b>L6ARDN70UW</b>	IC ID <b>2503A-RDM70UW</b> <b>2503A-RDN70UW</b>
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**ET3DV6 SN:1644****November 16, 2010****DASY/EASY - Parameters of Probe: ET3DV6 SN:1644****Calibration Parameter Determined in Body Tissue Simulating Media**

<b>f [MHz]</b>	<b>Validity [MHz]<sup>c</sup></b>	<b>Permittivity</b>	<b>Conductivity</b>	<b>ConvF X</b>	<b>ConvF Y</b>	<b>ConvF Z</b>	<b>Alpha</b>	<b>Depth Unc (k=2)</b>
750	$\pm 50$ / $\pm 100$	$55.5 \pm 5\%$	$0.96 \pm 5\%$	6.14	6.14	6.14	0.31	$3.06 \pm 11.0\%$
900	$\pm 50$ / $\pm 100$	$55.0 \pm 5\%$	$1.05 \pm 5\%$	5.93	5.93	5.93	0.36	$2.71 \pm 11.0\%$
1810	$\pm 50$ / $\pm 100$	$53.3 \pm 5\%$	$1.52 \pm 5\%$	4.59	4.59	4.59	0.32	$2.60 \pm 11.0\%$
2450	$\pm 50$ / $\pm 100$	$52.7 \pm 5\%$	$1.95 \pm 5\%$	4.05	4.05	4.05	0.99	$1.23 \pm 11.0\%$

<sup>c</sup> The validity of  $\pm 100$  MHz only applies for DASY v4.4 and higher (see Page 2). The uncertainty is the RSS of the ConvF uncertainty at calibration frequency and the uncertainty for the indicated frequency band.



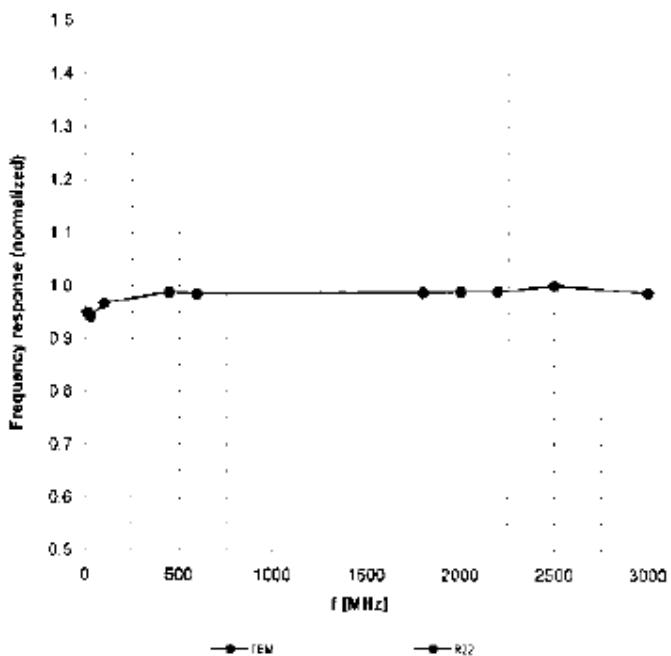
Document

**Appendix D for the BlackBerry® Smartphone Model  
RDM71UW/RDN71UW**Page  
**22(55)**

Author Data <b>Hang Wang</b>	Dates of Test <b>Jan 11 – Feb 15, 2011</b>	Test Report No <b>RTS-3640-1102-04a</b>	FCC ID: <b>L6ARDM70UW</b> <b>L6ARDN70UW</b>	IC ID <b>2503A-RDM70UW</b> <b>2503A-RDN70UW</b>
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**ET3DV6 SN:1644****November 16, 2010****Frequency Response of E-Field**

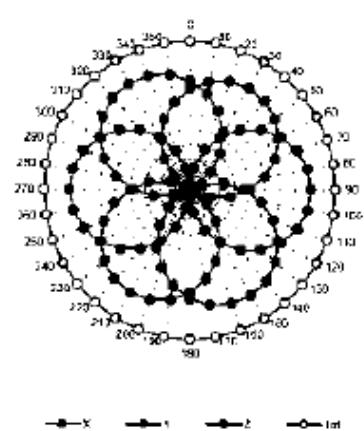
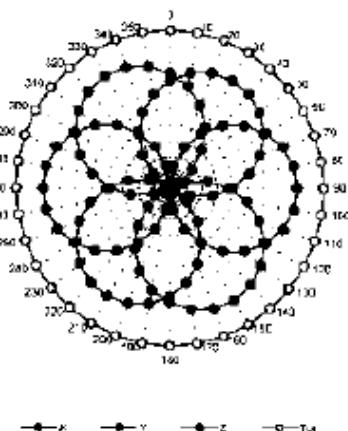
(TEM-Cell:Ri110 EXX, Waveguide: R22)

**Uncertainty of Frequency Response of E-field:  $\pm 6.3\%$  ( $k=2$ )**

Author Data <b>Hang Wang</b>	Dates of Test <b>Jan 11 – Feb 15, 2011</b>	Test Report No <b>RTS-3640-1102-04a</b>	FCC ID: <b>L6ARDM70UW</b> <b>L6ARDN70UW</b>	IC ID <b>2503A-RDM70UW</b> <b>2503A-RDN70UW</b>
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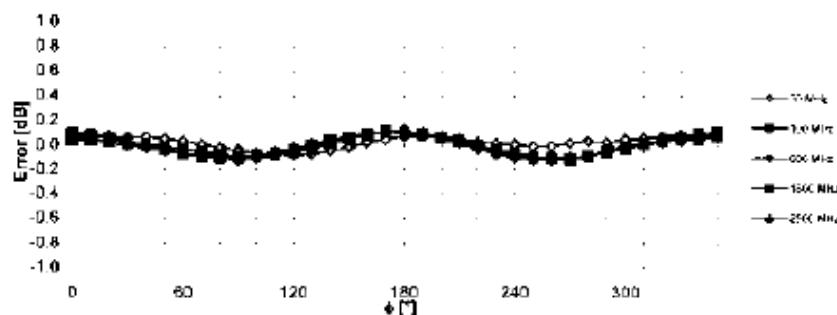
**ET3DV6 SN:1644**
**November 16, 2010**

### Receiving Pattern ( $\phi$ ), $\theta = 0^\circ$

 **$f = 500 \text{ MHz, TEM ifi110EXX}$** 

 **$f = 1800 \text{ MHz, WG R22}$** 


—●— X   —●— Y   —●— Z   —○— TM

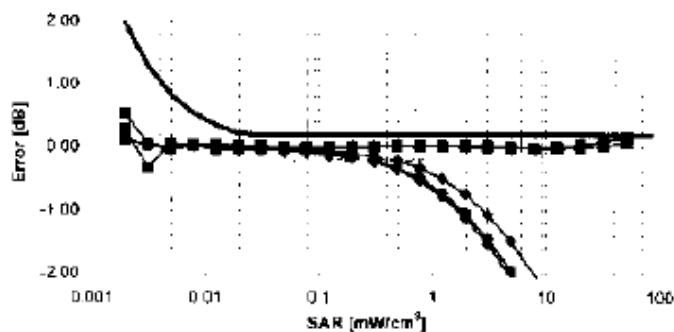
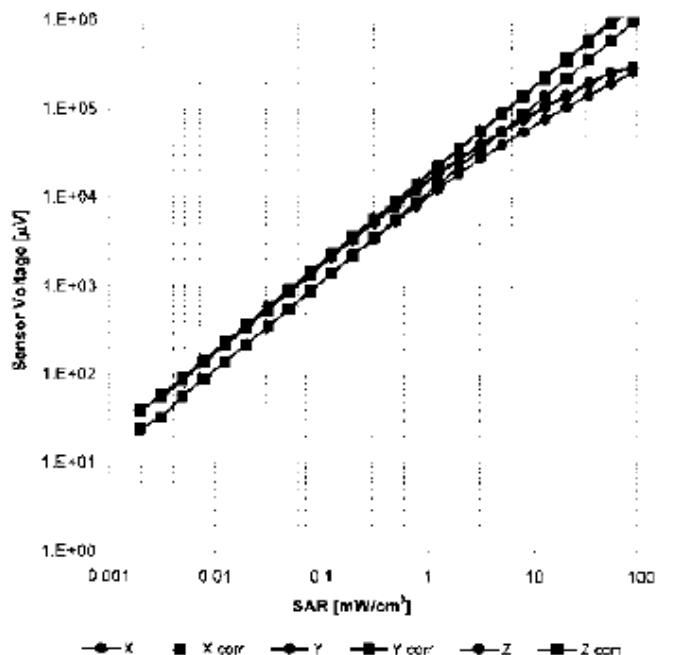
—●— X   —●— Y   —●— Z   —○— TM


**Uncertainty of Axial Isotropy Assessment:  $\pm 0.5\%$  ( $k=2$ )**

Author Data <b>Hang Wang</b>	Dates of Test <b>Jan 11 – Feb 15, 2011</b>	Test Report No <b>RTS-3640-1102-04a</b>	FCC ID: <b>L6ARDM70UW</b> <b>L6ARDN70UW</b>	IC ID <b>2503A-RDM70UW</b> <b>2503A-RDN70UW</b>
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**ET3DV6 SN:1644**
**November 16, 2010**

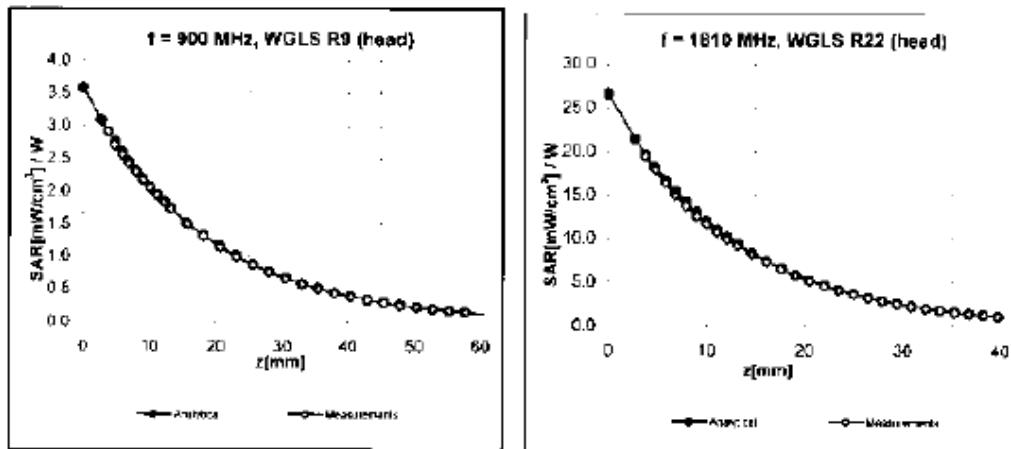
**Dynamic Range f(SAR<sub>head</sub>)**  
(TEM cell, f = 900 MHz)


**Uncertainty of Linearity Assessment:  $\pm 0.6\%$  ( $k=2$ )**

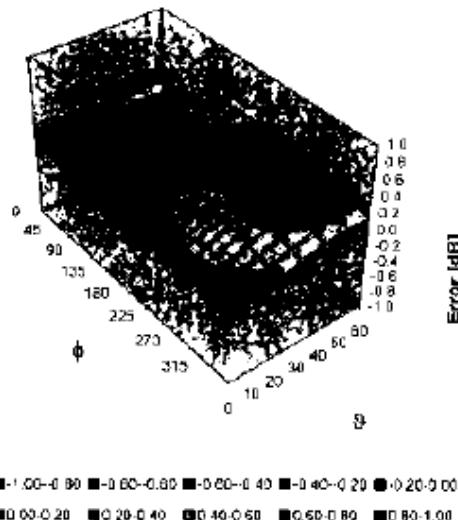
Author Data <b>Hang Wang</b>	Dates of Test <b>Jan 11 – Feb 15, 2011</b>	Test Report No <b>RTS-3640-1102-04a</b>	FCC ID: <b>L6ARDM70UW</b> <b>L6ARDN70UW</b>	IC ID <b>2503A-RDM70UW</b> <b>2503A-RDN70UW</b>
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**ET3DV6 SN:1644**
**November 16, 2010**

## Conversion Factor Assessment



## Deviation from Isotropy in HSL

**Error ( $\phi$ ,  $\theta$ ), f = 900 MHz**


■-1.00-0.80 ■-0.60-0.80 ■-0.40-0.40 ■-0.40-0.20 ■-0.20-0.00  
 ■0.00-0.20 ■0.20-0.40 ■0.40-0.60 ■0.60-0.80 ■0.80-1.00

**Uncertainty of Spherical Isotropy Assessment:  $\pm 2.5\%$  ( $k=2$ )**



Document

**Appendix D for the BlackBerry® Smartphone Model  
RDM71UW/RDN71UW**Page  
**26(55)**

Author Data <b>Hang Wang</b>	Dates of Test <b>Jan 11 – Feb 15, 2011</b>	Test Report No <b>RTS-3640-1102-04a</b>	FCC ID: <b>L6ARDM70UW</b> <b>L6ARDN70UW</b>	IC ID <b>2503A-RDM70UW</b> <b>2503A-RDN70UW</b>
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**ET3DV6 SN:1644****November 16, 2010****Other Probe Parameters**

Sensor Arrangement	Triangular
Connector Angle (°)	Not applicable
Mechanical Surface Detection Mode	enabled
Optical Surface Detection Mode	enabled
Probe Overall Length	337 mm
Probe Body Diameter	10 mm
Tip Length	10 mm
Tip Diameter	6.8 mm
Probe Tip to Sensor X Calibration Point	2.7 mm
Probe Tip to Sensor Y Calibration Point	2.7 mm
Probe Tip to Sensor Z Calibration Point	2.7 mm
Recommended Measurement Distance from Surface	3.7 mm



Document

**Appendix D for the BlackBerry® Smartphone Model  
RDM71UW/RDN71UW**

Page  
**27(55)**

Author Data <b>Hang Wang</b>	Dates of Test <b>Jan 11 – Feb 15, 2011</b>	Test Report No <b>RTS-3640-1102-04a</b>	FCC ID: <b>L6ARDM70UW</b> <b>L6ARDN70UW</b>	IC ID <b>2503A-RDM70UW</b> <b>2503A-RDN70UW</b>
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**Calibration Laboratory of**  
Schmid & Partner  
Engineering AG  
Zeughausstrasse 43, 8004 Zurich, Switzerland



**S** Schweizerischer Kalibrierdienst  
**C** Service suisse d'étalonnage  
**S** Servizio svizzero di taratura  
**S** Swiss Calibration Service

Accredited by the Swiss Accreditation Service (SAS)  
The Swiss Accreditation Service is one of the signatories to the EA  
Multilateral Agreement for the recognition of calibration certificates

Accreditation No.: **SCS 108**Client **RTS ( RIM Testing Services )**Certificate No: **D835V2-446\_Jan09**

## **CALIBRATION CERTIFICATE**

Object **D835V2 - SN: 446**Calibration procedure(s) **QA CAL-05.v7**  
Calibration procedure for dipole validation kitsCalibration date: **January 05, 2009**Condition of the calibrated item **In Tolerance**

This calibration certificate documents the traceability to national standards, which realize the physical units of measurements (SI).  
The measurements and the uncertainties with confidence probability are given on the following pages and are part of the certificate.

All calibrations have been conducted in the closed laboratory facility: environment temperature (22 ± 3)°C and humidity < 70%.

Calibration Equipment used (M&amp;TE critical for calibration)

Primary Standards	ID #	Cal Date (Certificate No.)	Scheduled Calibration
Power meter EPM-442A	GB37480704	08-Oct-08 (No. 217-00898)	Oct-09
Power sensor HP 8481A	US37292783	08-Oct-08 (No. 217-00898)	Oct-09
Reference 20 dB Attenuator	SN: 5086 (20g)	01-Jul-08 (No. 217-00864)	Jul-09
Type-N mismatch combination	SN: 5047.2 / 06327	01-Jul-08 (No. 217-00867)	Jul-09
Reference Probe ES3DV2	SN: 3025	28-Apr-08 (No. ES3-3025_Apr08)	Apr-09
DAE4	SN: 601	14-Mar-08 (No. DAE4-601_Mar08)	Mar-09

Secondary Standards	ID #	Check Date (in house)	Scheduled Check
Power sensor HP 8481A	MY41092317	18-Oct-02 (in house check Oct-07)	In house check: Oct-09
RF generator R&S SMT-06	100005	4-Aug-99 (in house check Oct-07)	In house check: Oct-09
Network Analyzer HP 8753E	US37390585 S4206	18-Oct-01 (in house check Oct-08)	In house check: Oct-09

Calibrated by:	Name	Function	Signature
	Jeton Kastrati	Laboratory Technician	

Approved by:	Name	Function	Signature
	Katja Pokovic	Technical Manager	

Issued: January 7, 2009

This calibration certificate shall not be reproduced except in full without written approval of the laboratory.

Certificate No: **D835V2-446\_Jan09**

Page 1 of 6



Document

**Appendix D for the BlackBerry® Smartphone Model  
RDM71UW/RDN71UW**Page  
**28(55)**

Author Data <b>Hang Wang</b>	Dates of Test <b>Jan 11 – Feb 15, 2011</b>	Test Report No <b>RTS-3640-1102-04a</b>	FCC ID: <b>L6ARDM70UW</b> <b>L6ARDN70UW</b>	IC ID <b>2503A-RDM70UW</b> <b>2503A-RDN70UW</b>
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 <p>Document  <b>Appendix D for the BlackBerry® Smartphone Model</b>  <b>RDM71UW/RDN71UW</b></p>				Page <b>29(55)</b>
Author Data <b>Hang Wang</b>	Dates of Test <b>Jan 11 – Feb 15, 2011</b>	Test Report No <b>RTS-3640-1102-04a</b>	FCC ID: <b>L6ARDM70UW</b> <b>L6ARDN70UW</b>	IC ID <b>2503A-RDM70UW</b> <b>2503A-RDN70UW</b>

**Calibration Laboratory of**  
**Schmid & Partner**  
**Engineering AG**  
**Zeughausstrasse 43, 8004 Zurich, Switzerland**



**S** Schweizerischer Kalibrierdienst  
**C** Service suisse d'étalonnage  
**S** Servizio svizzero di taratura  
**Swiss Calibration Service**

Accredited by the Swiss Accreditation Service (SAS)  
 The Swiss Accreditation Service is one of the signatories to the EA  
 Multilateral Agreement for the recognition of calibration certificates

Accreditation No.: **SCS 108**

#### **Glossary:**

<b>TSL</b>	tissue simulating liquid
<b>ConvF</b>	sensitivity in TSL / NORM x,y,z
<b>N/A</b>	not applicable or not measured

#### **Calibration is Performed According to the Following Standards:**

- IEEE Std 1528-2003, "IEEE Recommended Practice for Determining the Peak Spatial-Averaged Specific Absorption Rate (SAR) in the Human Head from Wireless Communications Devices: Measurement Techniques", December 2003
- IEC 62209-1, "Procedure to measure the Specific Absorption Rate (SAR) for hand-held devices used in close proximity to the ear (frequency range of 300 MHz to 3 GHz)", February 2005
- Federal Communications Commission Office of Engineering & Technology (FCC OET), "Evaluating Compliance with FCC Guidelines for Human Exposure to Radiofrequency Electromagnetic Fields; Additional Information for Evaluating Compliance of Mobile and Portable Devices with FCC Limits for Human Exposure to Radiofrequency Emissions", Supplement C (Edition 01-01) to Bulletin 65

#### **Additional Documentation:**

- DASY4/5 System Handbook

#### **Methods Applied and Interpretation of Parameters:**

- Measurement Conditions:** Further details are available from the Validation Report at the end of the certificate. All figures stated in the certificate are valid at the frequency indicated.
- Antenna Parameters with TSL:** The dipole is mounted with the spacer to position its feed point exactly below the center marking of the flat phantom section, with the arms oriented parallel to the body axis.
- Feed Point Impedance and Return Loss:** These parameters are measured with the dipole positioned under the liquid filled phantom. The impedance stated is transformed from the measurement at the SMA connector to the feed point. The Return Loss ensures low reflected power. No uncertainty required.
- Electrical Delay:** One-way delay between the SMA connector and the antenna feed point. No uncertainty required.
- SAR measured:** SAR measured at the stated antenna input power.
- SAR normalized:** SAR as measured, normalized to an input power of 1 W at the antenna connector.
- SAR for nominal TSL parameters:** The measured TSL parameters are used to calculate the nominal SAR result.



Document

**Appendix D for the BlackBerry® Smartphone Model  
RDM71UW/RDN71UW**Page  
**30(55)**

Author Data <b>Hang Wang</b>	Dates of Test <b>Jan 11 – Feb 15, 2011</b>	Test Report No <b>RTS-3640-1102-04a</b>	FCC ID: <b>L6ARDM70UW</b> <b>L6ARDN70UW</b>	IC ID <b>2503A-RDM70UW</b> <b>2503A-RDN70UW</b>
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Document

**Appendix D for the BlackBerry® Smartphone Model  
RDM71UW/RDN71UW**Page  
**31(55)**

Author Data <b>Hang Wang</b>	Dates of Test <b>Jan 11 – Feb 15, 2011</b>	Test Report No <b>RTS-3640-1102-04a</b>	FCC ID: <b>L6ARDM70UW</b> <b>L6ARDN70UW</b>	IC ID <b>2503A-RDM70UW</b> <b>2503A-RDN70UW</b>
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**Measurement Conditions**

DASY system configuration, as far as not given on page 1.

DASY Version	DASY5	V5.0
Extrapolation	Advanced Extrapolation	
Phantom	Modular Flat Phantom V4.9	
Distance Dipole Center - TSL	15 mm	with Spacer
Zoom Scan Resolution	dx, dy, dz = 5 mm	
Frequency	835 MHz ± 1 MHz	

**Head TSL parameters**

The following parameters and calculations were applied.

	Temperature	Permittivity	Conductivity
Nominal Head TSL parameters	22.0 °C	41.5	0.90 mho/m
Measured Head TSL parameters	(22.0 ± 0.2) °C	41.3 ± 6 %	0.91 mho/m ± 6 %
Head TSL temperature during test	(21.5 ± 0.2) °C	---	---

**SAR result with Head TSL**

SAR averaged over 1 cm <sup>3</sup> (1 g) of Head TSL	Condition	
SAR measured	250 mW input power	2.40 mW / g
SAR normalized	normalized to 1W	9.60 mW / g
SAR for nominal Head TSL parameters <sup>1</sup>	normalized to 1W	9.50 mW /g ± 17.0 % (k=2)

SAR averaged over 10 cm <sup>3</sup> (10 g) of Head TSL	condition	
SAR measured	250 mW input power	1.58 mW / g
SAR normalized	normalized to 1W	6.32 mW / g
SAR for nominal Head TSL parameters <sup>1</sup>	normalized to 1W	6.27 mW /g ± 16.5 % (k=2)

<sup>1</sup> Correction to nominal TSL parameters according to d), chapter "SAR Sensitivities"



Document

**Appendix D for the BlackBerry® Smartphone Model  
RDM71UW/RDN71UW**Page  
**32(55)**

Author Data <b>Hang Wang</b>	Dates of Test <b>Jan 11 – Feb 15, 2011</b>	Test Report No <b>RTS-3640-1102-04a</b>	FCC ID: <b>L6ARDM70UW</b> <b>L6ARDN70UW</b>	IC ID <b>2503A-RDM70UW</b> <b>2503A-RDN70UW</b>
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Document

**Appendix D for the BlackBerry® Smartphone Model  
RDM71UW/RDN71UW**Page  
**33(55)**

Author Data <b>Hang Wang</b>	Dates of Test <b>Jan 11 – Feb 15, 2011</b>	Test Report No <b>RTS-3640-1102-04a</b>	FCC ID: <b>L6ARDM70UW</b> <b>L6ARDN70UW</b>	IC ID <b>2503A-RDM70UW</b> <b>2503A-RDN70UW</b>
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**Appendix****Antenna Parameters with Head TSL**

Impedance, transformed to feed point	<b>49.8 Ω - 6.9 jΩ</b>
Return Loss	<b>- 23.3 dB</b>

**General Antenna Parameters and Design**

Electrical Delay (one direction)	<b>1.385 ns</b>
----------------------------------	-----------------

After long term use with 100W radiated power, only a slight warming of the dipole near the feedpoint can be measured.

The dipole is made of standard semirigid coaxial cable. The center conductor of the feeding line is directly connected to the second arm of the dipole. The antenna is therefore short-circuited for DC-signals.  
No excessive force must be applied to the dipole arms, because they might bend or the soldered connections near the feedpoint may be damaged.

**Additional EUT Data**

Manufactured by	<b>SPEAG</b>
Manufactured on	<b>October 24, 2001</b>



Document

**Appendix D for the BlackBerry® Smartphone Model  
RDM71UW/RDN71UW**Page  
**34(55)**

Author Data <b>Hang Wang</b>	Dates of Test <b>Jan 11 – Feb 15, 2011</b>	Test Report No <b>RTS-3640-1102-04a</b>	FCC ID: <b>L6ARDM70UW</b> <b>L6ARDN70UW</b>	IC ID <b>2503A-RDM70UW</b> <b>2503A-RDN70UW</b>
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Document

**Appendix D for the BlackBerry® Smartphone Model  
RDM71UW/RDN71UW**Page  
**35(55)**

Author Data <b>Hang Wang</b>	Dates of Test <b>Jan 11 – Feb 15, 2011</b>	Test Report No <b>RTS-3640-1102-04a</b>	FCC ID: <b>L6ARDM70UW</b> <b>L6ARDN70UW</b>	IC ID <b>2503A-RDM70UW</b> <b>2503A-RDN70UW</b>
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**DASY5 Validation Report for Head TSL**

Date/Time: 05.01.2009 10:38:06

Test Laboratory: SPEAG, Zurich, Switzerland

**DUT: Dipole 835 MHz; Type: D835V2; Serial: D835V2 - SN:446**

Communication System: CW-835; Frequency: 835 MHz; Duty Cycle: 1:1

Medium: HSL 900 MHz

Medium parameters used:  $f = 835$  MHz;  $\sigma = 0.91$  mho/m;  $\epsilon_r = 41.1$ ;  $\rho = 1000$  kg/m<sup>3</sup>

Phantom section: Flat Section

Measurement Standard: DASY5 (IEEE/IEC)

DASY5 Configuration:

- Probe: ES3DV2 - SN3025; ConvF(5.97, 5.97, 5.97); Calibrated: 28.04.2008
- Sensor-Surface: 3.4mm (Mechanical Surface Detection)
- Electronics: DAE4 Sn601; Calibrated: 14.03.2008
- Phantom: Flat Phantom 4.9L; Type: QD000P49AA; Serial: 1001
- Measurement SW: DASY5, V5.0 Build 120; SEMCAD X Version 13.4 Build 45

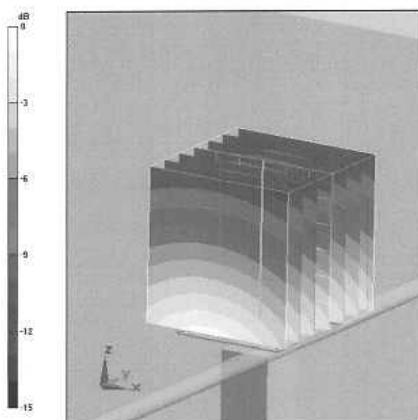
**Pin=250mW; dip=15mm; dist=3.4mm/Zoom Scan (7x7x7)/Cube 0:** Measurement grid: dx=5mm, dy=5mm, dz=5mm

Reference Value = 55.7 V/m; Power Drift = 0.024 dB

Peak SAR (extrapolated) = 3.54 W/kg

**SAR(1 g) = 2.4 mW/g; SAR(10 g) = 1.58 mW/g**

Maximum value of SAR (measured) = 2.7 mW/g



0 dB = 2.7mW/g

Certificate No: D835V2-446\_Jan09

Page 5 of 6

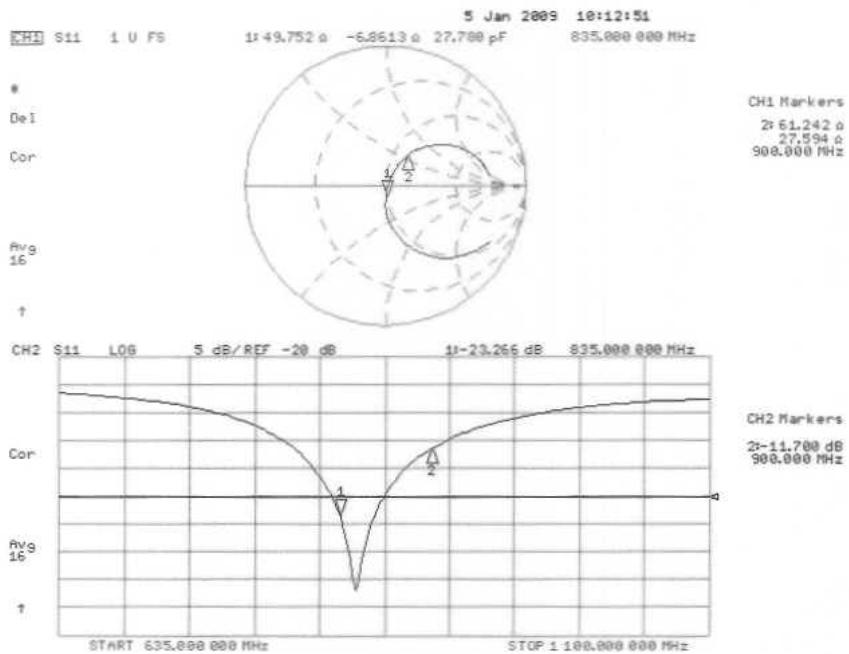


Document

**Appendix D for the BlackBerry® Smartphone Model  
RDM71UW/RDN71UW**Page  
**36(55)**

Author Data <b>Hang Wang</b>	Dates of Test <b>Jan 11 – Feb 15, 2011</b>	Test Report No <b>RTS-3640-1102-04a</b>	FCC ID: <b>L6ARDM70UW</b> <b>L6ARDN70UW</b>	IC ID <b>2503A-RDM70UW</b> <b>2503A-RDN70UW</b>
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Author Data <b>Hang Wang</b>	Dates of Test <b>Jan 11 – Feb 15, 2011</b>	Test Report No <b>RTS-3640-1102-04a</b>	FCC ID: <b>L6ARDM70UW</b> <b>L6ARDN70UW</b>	IC ID <b>2503A-RDM70UW</b> <b>2503A-RDN70UW</b>
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**Impedance Measurement Plot for Head TSL**




Document

**Appendix D for the BlackBerry® Smartphone Model  
RDM71UW/RDN71UW**Page  
**38(55)**

Author Data <b>Hang Wang</b>	Dates of Test <b>Jan 11 – Feb 15, 2011</b>	Test Report No <b>RTS-3640-1102-04a</b>	FCC ID: <b>L6ARDM70UW</b> <b>L6ARDN70UW</b>	IC ID <b>2503A-RDM70UW</b> <b>2503A-RDN70UW</b>
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Document

**Appendix D for the BlackBerry® Smartphone Model  
RDM71UW/RDN71UW**

Page  
**39(55)**

Author Data <b>Hang Wang</b>	Dates of Test <b>Jan 11 – Feb 15, 2011</b>	Test Report No <b>RTS-3640-1102-04a</b>	FCC ID: <b>L6ARDM70UW</b> <b>L6ARDN70UW</b>	IC ID <b>2503A-RDM70UW</b> <b>2503A-RDN70UW</b>
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Calibration Laboratory of  
Schmid & Partner  
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Zeughausstrasse 43, 8004 Zurich, Switzerland



**S** Schweizerischer Kalibrierdienst  
**C** Service suisse d'étalonnage  
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**S** Swiss Calibration Service

Accredited by the Swiss Accreditation Service (SAS)  
The Swiss Accreditation Service is one of the signatories to the EA  
Multilateral Agreement for the recognition of calibration certificates

Accreditation No.: **SCS 108**Client **RTS (RIM Testing Services)**Certificate No: **D1900V2-545-Jan09**

## CALIBRATION CERTIFICATE

Object **D1900V2 - SN: 545**Calibration procedure(s) **QA CAL-05.v7**  
Calibration procedure for dipole validation kitsCalibration date: **January 06, 2009**Condition of the calibrated item **In Tolerance**

This calibration certificate documents the traceability to national standards, which realize the physical units of measurements (SI).  
The measurements and the uncertainties with confidence probability are given on the following pages and are part of the certificate.

All calibrations have been conducted in the closed laboratory facility: environment temperature  $(22 \pm 3)^\circ\text{C}$  and humidity  $< 70\%$ .

Calibration Equipment used (M&amp;TE critical for calibration)

Primary Standards	ID #	Cal Date (Calibrated by, Certificate No.)	Scheduled Calibration
Power meter EPM-442A	GB37480704	08-Oct-08 (No. 217-00898)	Oct-09
Power sensor HP 8481A	US37292783	08-Oct-08 (No. 217-00898)	Oct-09
Reference 20 dB Attenuator	SN: 5086 (20g)	01-Jul-08 (No. 217-00864)	Jul-09
Type-N mismatch combination	SN: 5047.2 / 06327	01-Jul-08 (No. 217-00867)	Jul-09
Reference Probe ES3DV2	SN: 3025	28-Apr-08 (No. ES3-3025_Apr08)	Apr-09
DAE4	SN: 601	14-Mar-08 (No. DAE4-601_Mar08)	Mar-09
Secondary Standards	ID #	Check Date (in house)	Scheduled Check
Power sensor HP 8481A	MY41092317	18-Oct-02 (in house check Oct-07)	In house check: Oct-09
RF generator R&S SMT-06	100005	4-Aug-99 (in house check Oct-07)	In house check: Oct-09
Network Analyzer HP 8753E	US37390585 S4206	18-Oct-01 (in house check Oct-08)	In house check: Oct-09

Calibrated by:	Name <b>Jeton Kazbati</b>	Function <b>Laboratory Technician</b>	Signature 
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Approved by:	Name <b>Katja Pokovic</b>	Function <b>Technical Manager</b>	Signature 
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Issued: January 7, 2009

This calibration certificate shall not be reproduced except in full without written approval of the laboratory.

Author Data <b>Hang Wang</b>	Dates of Test <b>Jan 11 – Feb 15, 2011</b>	Test Report No <b>RTS-3640-1102-04a</b>	FCC ID: <b>L6ARDM70UW</b> <b>L6ARDN70UW</b>	IC ID <b>2503A-RDM70UW</b> <b>2503A-RDN70UW</b>
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**Zeughausstrasse 43, 8004 Zurich, Switzerland**



**S** Schweizerischer Kalibrierdienst  
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**S** Swiss Calibration Service

Accredited by the Swiss Accreditation Service (SAS)  
 The Swiss Accreditation Service is one of the signatories to the EA  
 Multilateral Agreement for the recognition of calibration certificates

Accreditation No.: **SCS 108**

#### **Glossary:**

<b>TSL</b>	tissue simulating liquid
<b>ConvF</b>	sensitivity in TSL / NORM x,y,z
<b>N/A</b>	not applicable or not measured

#### **Calibration is Performed According to the Following Standards:**

- IEEE Std 1528-2003, "IEEE Recommended Practice for Determining the Peak Spatial-Averaged Specific Absorption Rate (SAR) in the Human Head from Wireless Communications Devices: Measurement Techniques", December 2003
- CENELEC EN 50361, "Basic standard for the measurement of Specific Absorption Rate related to human exposure to electromagnetic fields from mobile phones (300 MHz - 3 GHz)", July 2001
- Federal Communications Commission Office of Engineering & Technology (FCC OET), "Evaluating Compliance with FCC Guidelines for Human Exposure to Radiofrequency Electromagnetic Fields; Additional Information for Evaluating Compliance of Mobile and Portable Devices with FCC Limits for Human Exposure to Radiofrequency Emissions", Supplement C (Edition 01-01) to Bulletin 65

#### **Additional Documentation:**

- DASY4/5 System Handbook

#### **Methods Applied and Interpretation of Parameters:**

- Measurement Conditions:* Further details are available from the Validation Report at the end of the certificate. All figures stated in the certificate are valid at the frequency indicated.
- Antenna Parameters with TSL:* The dipole is mounted with the spacer to position its feed point exactly below the center marking of the flat phantom section, with the arms oriented parallel to the body axis.
- Feed Point Impedance and Return Loss:* These parameters are measured with the dipole positioned under the liquid filled phantom. The impedance stated is transformed from the measurement at the SMA connector to the feed point. The Return Loss ensures low reflected power. No uncertainty required.
- Electrical Delay:* One-way delay between the SMA connector and the antenna feed point. No uncertainty required.
- SAR measured:* SAR measured at the stated antenna input power.
- SAR normalized:* SAR as measured, normalized to an input power of 1 W at the antenna connector.
- SAR for nominal TSL parameters:* The measured TSL parameters are used to calculate the nominal SAR result.



Document

**Appendix D for the BlackBerry® Smartphone Model  
RDM71UW/RDN71UW**Page  
**41(55)**

Author Data <b>Hang Wang</b>	Dates of Test <b>Jan 11 – Feb 15, 2011</b>	Test Report No <b>RTS-3640-1102-04a</b>	FCC ID: <b>L6ARDM70UW</b> <b>L6ARDN70UW</b>	IC ID <b>2503A-RDM70UW</b> <b>2503A-RDN70UW</b>
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**Measurement Conditions**

DASY system configuration, as far as not given on page 1.

DASY Version	DASY5	V5.0
Extrapolation	Advanced Extrapolation	
Phantom	Modular Flat Phantom V5.0	
Distance Dipole Center - TSL	10 mm	with Spacer
Zoom Scan Resolution	dx, dy, dz = 5 mm	
Frequency	1900 MHz ± 1 MHz	

**Head TSL parameters**

The following parameters and calculations were applied.

	Temperature	Permittivity	Conductivity
Nominal Head TSL parameters	22.0 °C	40.0	1.40 mho/m
Measured Head TSL parameters	(22.0 ± 0.2) °C	39.2 ± 6 %	1.47 mho/m ± 6 %
Head TSL temperature during test	(21.0 ± 0.2) °C	—	—

**SAR result with Head TSL**

SAR averaged over 1 cm <sup>3</sup> (1 g) of Head TSL	condition	
SAR measured	250 mW input power	10.2 mW / g
SAR normalized	normalized to 1W	40.8 mW / g
SAR for nominal Head TSL parameters <sup>1</sup>	normalized to 1W	39.5 mW / g ± 17.0 % (k=2)

SAR averaged over 10 cm <sup>3</sup> (10 g) of Head TSL	Condition	
SAR measured	250 mW input power	5.29 mW / g
SAR normalized	normalized to 1W	21.2 mW / g
SAR for nominal Head TSL parameters <sup>1</sup>	normalized to 1W	20.8 mW / g ± 16.5 % (k=2)

<sup>1</sup> Correction to nominal TSL parameters according to d), chapter "SAR Sensitivities"



Document

**Appendix D for the BlackBerry® Smartphone Model  
RDM71UW/RDN71UW**Page  
**42(55)**

Author Data <b>Hang Wang</b>	Dates of Test <b>Jan 11 – Feb 15, 2011</b>	Test Report No <b>RTS-3640-1102-04a</b>	FCC ID: <b>L6ARDM70UW</b> <b>L6ARDN70UW</b>	IC ID <b>2503A-RDM70UW</b> <b>2503A-RDN70UW</b>
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## Appendix

**Antenna Parameters with Head TSL**

Impedance, transformed to feed point	49.9 $\Omega$ + 1.9 $j\Omega$
Return Loss	-34.4 dB

**General Antenna Parameters and Design**

Electrical Delay (one direction)	1.197 ns
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After long term use with 100W radiated power, only a slight warming of the dipole near the feedpoint can be measured.

The dipole is made of standard semirigid coaxial cable. The center conductor of the feeding line is directly connected to the second arm of the dipole. The antenna is therefore short-circuited for DC-signals.

No excessive force must be applied to the dipole arms, because they might bend or the soldered connections near the feedpoint may be damaged.

**Additional EUT Data**

Manufactured by	SPEAG
Manufactured on	November 15, 2001

Author Data <b>Hang Wang</b>	Dates of Test <b>Jan 11 – Feb 15, 2011</b>	Test Report No <b>RTS-3640-1102-04a</b>	FCC ID: <b>L6ARDM70UW</b> <b>L6ARDN70UW</b>	IC ID <b>2503A-RDM70UW</b> <b>2503A-RDN70UW</b>
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**DASY5 Validation Report for Head TSL**

Date/Time: 06.01.2009 13:17:58

Test Laboratory: SPEAG, Zurich, Switzerland

**DUT: Dipole 1900 MHz; Type: D1900V2; Serial: D1900V2 - SN:545**

Communication System: CW; Frequency: 1900 MHz; Duty Cycle: 1:1

Medium: HSL U10 BB

Medium parameters used:  $f = 1900$  MHz;  $\sigma = 1.47$  mho/m;  $\epsilon_r = 39.4$ ;  $\rho = 1000$  kg/m<sup>3</sup>

Phantom section: Flat Section

Measurement Standard: DASY5 (IEEE/IEC)

## DASY5 Configuration:

- Probe: ES3DV2 - SN3025; ConvF(4.9, 4.9, 4.9); Calibrated: 28.04.2008
- Sensor-Surface: 3.4mm (Mechanical Surface Detection)
- Electronics: DAE4 Sn601; Calibrated: 14.03.2008
- Phantom: Flat Phantom: 5.0 (front); Type: QD000P50AA; Serial: 1001
- Measurement SW: DASY5, V5.0 Build 120; SEMCAD X Version 13.4 Build 45

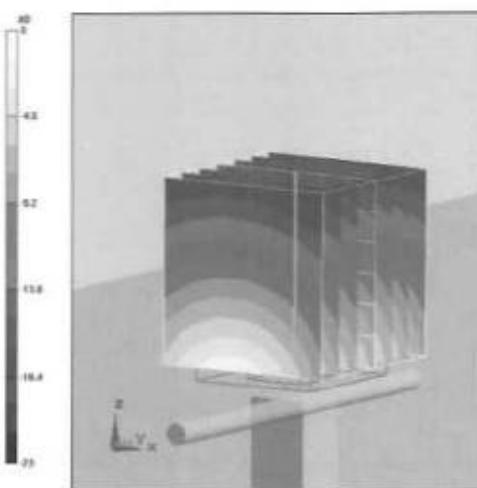
**Pin = 250 mW; dip = 10 mm, scan at 3.4mm/Zoom Scan (dist=3.4mm, probe 0deg)****(7x7x7)/Cube 0: Measurement grid: dx=5mm, dy=5mm, dz=5mm**

Reference Value = 92.5 V/m; Power Drift = 0.037 dB

Peak SAR (extrapolated) = 19 W/kg

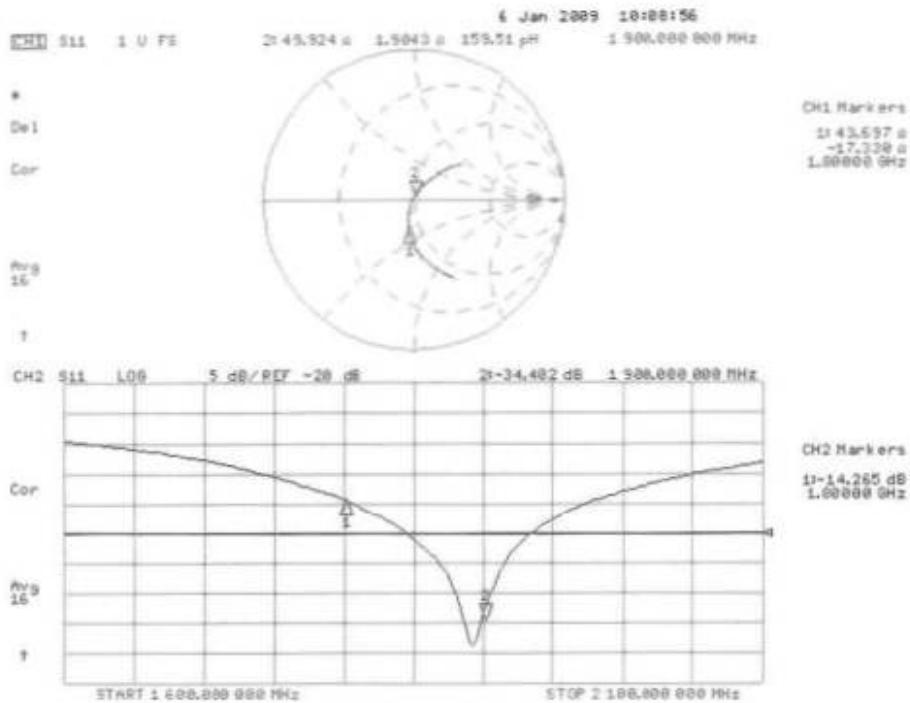
SAR(1 g) = 10.2 mW/g; SAR(10 g) = 5.29 mW/g

Maximum value of SAR (measured) = 12 mW/g



0 dB = 12mW/g

Author Data <b>Hang Wang</b>	Dates of Test <b>Jan 11 – Feb 15, 2011</b>	Test Report No <b>RTS-3640-1102-04a</b>	FCC ID: <b>L6ARDM70UW</b> <b>L6ARDN70UW</b>	IC ID <b>2503A-RDM70UW</b> <b>2503A-RDN70UW</b>
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**Impedance Measurement Plot for Head TSL**




Document

**Appendix D for the BlackBerry® Smartphone Model  
RDM71UW/RDN71UW**

Page  
**45(55)**

Author Data <b>Hang Wang</b>	Dates of Test <b>Jan 11 – Feb 15, 2011</b>	Test Report No <b>RTS-3640-1102-04a</b>	FCC ID: <b>L6ARDM70UW</b> <b>L6ARDN70UW</b>	IC ID <b>2503A-RDM70UW</b> <b>2503A-RDN70UW</b>
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**S** Swiss Calibration Service

Accredited by the Swiss Accreditation Service (SAS)  
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Multilateral Agreement for the recognition of calibration certificates

Accreditation No.: **SCS 108**Client **RTS (RIM Testing Services)**Certificate No: **D2450V2-747\_Nov09**

## **CALIBRATION CERTIFICATE**

Object **D2450V2 - SN: 747**Calibration procedure(s) **QA CAL-05.v7**  
**Calibration procedure for dipole validation kits**Calibration date: **November 11, 2009**

This calibration certificate documents the traceability to national standards, which realize the physical units of measurements (SI). The measurements and the uncertainties with confidence probability are given on the following pages and are part of the certificate.

All calibrations have been conducted in the closed laboratory facility: environment temperature (22 ± 3)°C and humidity < 70%.

Calibration Equipment used (M&amp;TE critical for calibration)

Primary Standards	ID #	Cal Date (Certificate No.)	Scheduled Calibration
Power meter EPM-442A	GB37480704	06-Oct-09 (No. 217-01086)	Oct-10
Power sensor HP 8481A	US37292783	06-Oct-09 (No. 217-01086)	Oct-10
Reference 20 dB Attenuator	SN: 5086 (20g)	31-Mar-09 (No. 217-01025)	Mar-10
Type-N mismatch combination	SN: 5047.2 / 06327	31-Mar-09 (No. 217-01029)	Mar-10
Reference Probe ES3DV3	SN: 3205	26-Jun-09 (No. ES3-3205_Jun09)	Jun-10
DAE4	SN: 601	07-Mar-09 (No. DAE4-601_Mar09)	Mar-10
Secondary Standards	ID #	Check Date (in house)	Scheduled Check
Power sensor HP 8481A	MY41092317	18-Oct-02 (in house check Oct-09)	In house check: Oct-11
RF generator R&S SMT-06	100005	4-Aug-99 (in house check Oct-09)	In house check: Oct-11
Network Analyzer HP 8753E	US37390585 S4206	18-Oct-01 (in house check Oct-09)	In house check: Oct-10

Calibrated by: **Mike Meil** Function: **Laboratory Technician** Signature:

Approved by: **Katja Pokovic** Technical Manager:

Issued: November 16, 2009

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Certificate No: D2450V2-747\_Nov09

Page 1 of 6



Document

**Appendix D for the BlackBerry® Smartphone Model  
RDM71UW/RDN71UW**Page  
**46(55)**

Author Data <b>Hang Wang</b>	Dates of Test <b>Jan 11 – Feb 15, 2011</b>	Test Report No <b>RTS-3640-1102-04a</b>	FCC ID: <b>L6ARDM70UW</b> <b>L6ARDN70UW</b>	IC ID <b>2503A-RDM70UW</b> <b>2503A-RDN70UW</b>
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 <p>Document  <b>Appendix D for the BlackBerry® Smartphone Model</b>  <b>RDM71UW/RDN71UW</b></p>				Page <b>47(55)</b>
Author Data <b>Hang Wang</b>	Dates of Test <b>Jan 11 – Feb 15, 2011</b>	Test Report No <b>RTS-3640-1102-04a</b>	FCC ID: <b>L6ARDM70UW</b> <b>L6ARDN70UW</b>	IC ID <b>2503A-RDM70UW</b> <b>2503A-RDN70UW</b>

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**S** Swiss Calibration Service

Accredited by the Swiss Accreditation Service (SAS)  
The Swiss Accreditation Service is one of the signatories to the EA  
Multilateral Agreement for the recognition of calibration certificates

Accreditation No.: **SCS 108**

#### **Glossary:**

TSL	tissue simulating liquid
ConvF	sensitivity in TSL / NORM x,y,z
N/A	not applicable or not measured

#### **Calibration is Performed According to the Following Standards:**

- IEEE Std 1528-2003, "IEEE Recommended Practice for Determining the Peak Spatial-Averaged Specific Absorption Rate (SAR) in the Human Head from Wireless Communications Devices: Measurement Techniques", December 2003
- IEC 62209-1, "Procedure to measure the Specific Absorption Rate (SAR) for hand-held devices used in close proximity to the ear (frequency range of 300 MHz to 3 GHz)", February 2005
- Federal Communications Commission Office of Engineering & Technology (FCC OET), "Evaluating Compliance with FCC Guidelines for Human Exposure to Radiofrequency Electromagnetic Fields; Additional Information for Evaluating Compliance of Mobile and Portable Devices with FCC Limits for Human Exposure to Radiofrequency Emissions", Supplement C (Edition 01-01) to Bulletin 65

#### **Additional Documentation:**

- DASY4/5 System Handbook

#### **Methods Applied and Interpretation of Parameters:**

- Measurement Conditions:** Further details are available from the Validation Report at the end of the certificate. All figures stated in the certificate are valid at the frequency indicated.
- Antenna Parameters with TSL:** The dipole is mounted with the spacer to position its feed point exactly below the center marking of the flat phantom section, with the arms oriented parallel to the body axis.
- Feed Point Impedance and Return Loss:** These parameters are measured with the dipole positioned under the liquid filled phantom. The impedance stated is transformed from the measurement at the SMA connector to the feed point. The Return Loss ensures low reflected power. No uncertainty required.
- Electrical Delay:** One-way delay between the SMA connector and the antenna feed point. No uncertainty required.
- SAR measured:** SAR measured at the stated antenna input power.
- SAR normalized:** SAR as measured, normalized to an input power of 1 W at the antenna connector.
- SAR for nominal TSL parameters:** The measured TSL parameters are used to calculate the nominal SAR result.



Document

**Appendix D for the BlackBerry® Smartphone Model  
RDM71UW/RDN71UW**Page  
**48(55)**

Author Data <b>Hang Wang</b>	Dates of Test <b>Jan 11 – Feb 15, 2011</b>	Test Report No <b>RTS-3640-1102-04a</b>	FCC ID: <b>L6ARDM70UW</b> <b>L6ARDN70UW</b>	IC ID <b>2503A-RDM70UW</b> <b>2503A-RDN70UW</b>
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Document

**Appendix D for the BlackBerry® Smartphone Model  
RDM71UW/RDN71UW**Page  
**49(55)**

Author Data <b>Hang Wang</b>	Dates of Test <b>Jan 11 – Feb 15, 2011</b>	Test Report No <b>RTS-3640-1102-04a</b>	FCC ID: <b>L6ARDM70UW</b> <b>L6ARDN70UW</b>	IC ID <b>2503A-RDM70UW</b> <b>2503A-RDN70UW</b>
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**Measurement Conditions**

DASY system configuration, as far as not given on page 1.

<b>DASY Version</b>	DASY5	V5.2
<b>Extrapolation</b>	Advanced Extrapolation	
<b>Phantom</b>	Modular Flat Phantom V4.9	
<b>Distance Dipole Center - TSL</b>	10 mm	with Spacer
<b>Zoom Scan Resolution</b>	dx, dy, dz = 5 mm	
<b>Frequency</b>	2450 MHz ± 1 MHz	

**Head TSL parameters**

The following parameters and calculations were applied.

	<b>Temperature</b>	<b>Permittivity</b>	<b>Conductivity</b>
<b>Nominal Head TSL parameters</b>	22.0 °C	39.2	1.80 mho/m
<b>Measured Head TSL parameters</b>	(22.0 ± 0.2) °C	39.1 ± 6 %	1.78 mho/m ± 6 %
<b>Head TSL temperature during test</b>	(21.3 ± 0.2) °C	---	---

**SAR result with Head TSL**

<b>SAR averaged over 1 cm<sup>3</sup> (1 g) of Head TSL</b>	Condition	
SAR measured	250 mW input power	13.3 mW / g
SAR normalized	normalized to 1W	53.2 mW / g
SAR for nominal Head TSL parameters	normalized to 1W	53.4 mW / g ± 17.0 % (k=2)

<b>SAR averaged over 10 cm<sup>3</sup> (10 g) of Head TSL</b>	condition	
SAR measured	250 mW input power	6.23 mW / g
SAR normalized	normalized to 1W	24.9 mW / g
SAR for nominal Head TSL parameters	normalized to 1W	24.9 mW / g ± 16.5 % (k=2)



Document

**Appendix D for the BlackBerry® Smartphone Model  
RDM71UW/RDN71UW**Page  
**50(55)**

Author Data <b>Hang Wang</b>	Dates of Test <b>Jan 11 – Feb 15, 2011</b>	Test Report No <b>RTS-3640-1102-04a</b>	FCC ID: <b>L6ARDM70UW</b> <b>L6ARDN70UW</b>	IC ID <b>2503A-RDM70UW</b> <b>2503A-RDN70UW</b>
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Document

**Appendix D for the BlackBerry® Smartphone Model  
RDM71UW/RDN71UW**Page  
**51(55)**

Author Data <b>Hang Wang</b>	Dates of Test <b>Jan 11 – Feb 15, 2011</b>	Test Report No <b>RTS-3640-1102-04a</b>	FCC ID: <b>L6ARDM70UW</b> <b>L6ARDN70UW</b>	IC ID <b>2503A-RDM70UW</b> <b>2503A-RDN70UW</b>
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**Appendix****Antenna Parameters with Head TSL**

Impedance, transformed to feed point	<b>51.9 <math>\Omega</math> + 0.9 <math>j\Omega</math></b>
Return Loss	<b>- 33.9 dB</b>

**General Antenna Parameters and Design**

Electrical Delay (one direction)	<b>1.161 ns</b>
----------------------------------	-----------------

After long term use with 100W radiated power, only a slight warming of the dipole near the feedpoint can be measured.

The dipole is made of standard semirigid coaxial cable. The center conductor of the feeding line is directly connected to the second arm of the dipole. The antenna is therefore short-circuited for DC-signals.

No excessive force must be applied to the dipole arms, because they might bend or the soldered connections near the feedpoint may be damaged.

**Additional EUT Data**

Manufactured by	<b>SPEAG</b>
Manufactured on	<b>December 01, 2003</b>



Document

**Appendix D for the BlackBerry® Smartphone Model  
RDM71UW/RDN71UW**Page  
**52(55)**

Author Data <b>Hang Wang</b>	Dates of Test <b>Jan 11 – Feb 15, 2011</b>	Test Report No <b>RTS-3640-1102-04a</b>	FCC ID: <b>L6ARDM70UW</b> <b>L6ARDN70UW</b>	IC ID <b>2503A-RDM70UW</b> <b>2503A-RDN70UW</b>
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**DASY5 Validation Report for Head TSL**

Date/Time: 11.11.2009 15:04:10

Test Laboratory: SPEAG, Zurich, Switzerland

**DUT: Dipole 2450 MHz; Type: D2450V2; Serial: D2450V2 - SN:747**

Communication System: CW; Frequency: 2450 MHz; Duty Cycle: 1:1

Medium: HSL U11 BB

Medium parameters used:  $f = 2450$  MHz;  $\sigma = 1.79$  mho/m;  $\epsilon_r = 39.2$ ;  $\rho = 1000$  kg/m<sup>3</sup>

Phantom section: Flat Section

Measurement Standard: DASY5 (IEEE/IEC/ANSI C63.19-2007)

DASY5 Configuration:

- Probe: ES3DV3 - SN3205; ConvF(4.53, 4.53, 4.53); Calibrated: 26.06.2009
- Sensor-Surface: 3mm (Mechanical Surface Detection)
- Electronics: DAE4 Sn601; Calibrated: 07.03.2009
- Phantom: Flat Phantom 5.0 (front); Type: QD000P50AA; Serial: 1001
- Measurement SW: DASY5, V5.2 Build 157; SEMCAD X Version 14.0 Build 57

**Head/d=10mm, Pin=250 mW, dist=3.0mm (ES-Probe)/Zoom Scan (7x7x7) (7x7x7)/Cube 0:**

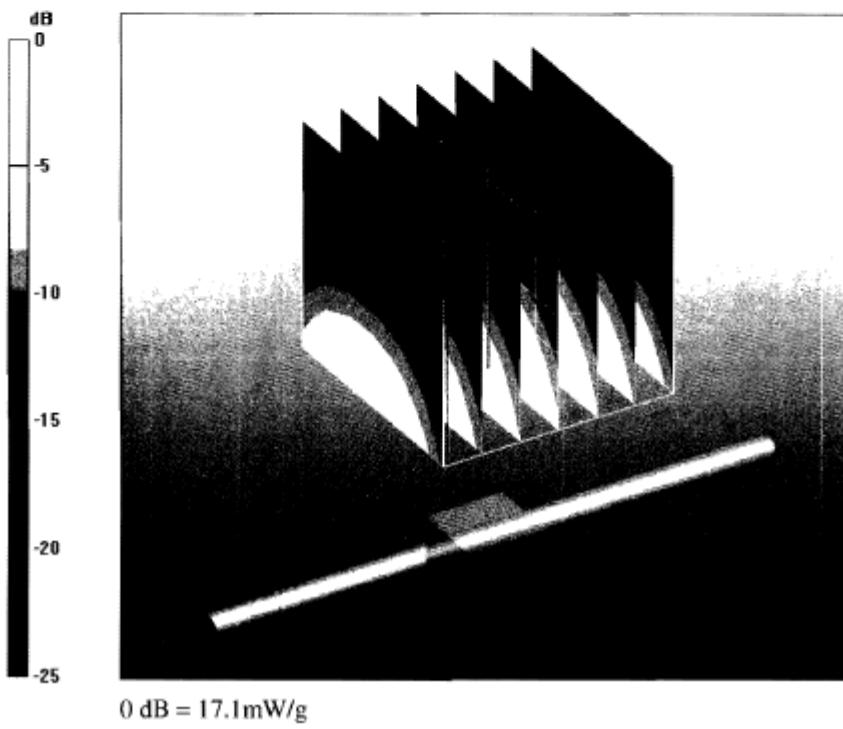
Measurement grid: dx=5mm, dy=5mm, dz=5mm

Reference Value = 101.3 V/m; Power Drift = 0.067 dB

Peak SAR (extrapolated) = 27 W/kg

**SAR(1 g) = 13.3 mW/g; SAR(10 g) = 6.23 mW/g**

Maximum value of SAR (measured) = 17.1 mW/g





Document

**Appendix D for the BlackBerry® Smartphone Model  
RDM71UW/RDN71UW**Page  
**54(55)**

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Document

**Appendix D for the BlackBerry® Smartphone Model  
RDM71UW/RDN71UW**Page  
**55(55)**

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**Impedance Measurement Plot for Head TSL**